# Charge transport properties of heavily irradiated SC CVD diamond detectors



Michal Pomorski Eleni Berdermann GSI Darmstadt



Wim de Boer Alex Furgeri Christian Sanders University of Karlsruhe

> John Morse ESRF

for the NoRHDia collaboration



- Motivation
- Samples and TCT
- Non irradiated detectors
- Heavily irradiated detectors
  - priming
  - annealing

#### Motivation

- a lot of data on RH PC-CVD diamond detectors.... RD42

 a lot of data on radiation related defects in diamond, but studied with optical methods or EPR no information on charge transport

-some data on irradiated SC (natural, HPHT) diamond detectors

... no data on SC-CVD diamond detectors(?)

### Samples - SC CVD diamonds

#### PRODUCER: Element Six, Ascot, UK

free standing <100> oriented diamond films size - 5 x 5 x 0.3-0.5 [mm<sup>3</sup>]

#### **DETECTOR FABRICATION**

surface cleaning and oxidation --> H<sub>2</sub>SO<sub>4</sub> + KNO<sub>3</sub> (boiling), DI water

sputtered circular electrodes (parallel plate geometry) annealing at 600°C (if Cr+Au)







# **TCT-Transient Current Technique**



a-particle's ENERGY (5.48 Mev) range in diamond ~14µm; detector thickness ~300µm - 500µm GENERATED CHARGE ~ 430 000 e-h --> 68 fC << UC<sub>b</sub> operation in non space charge limited regime

SIGNAL INDUCED DUE TO e or h DRIFT

#### **INFORMATION ON:**

- charge carriers drift velocity vs. E, saturation velocity
- effective mobility and low field mobility
- charge collection
- Effective trapping time
- $N_{eff}$  effective space charge

### **Readout electronics**



#### **BROAD BAND ELECTRONICS:**

50Ω impedance DBA II, bandwidth **2.4 GHz**, gain ~120 Digital Scope, bandwidth **3GHz**, 20GS/s, signal proc.

Limitation at low bias due to electronic noise (rms~5000 e)

INFLUENCE OF ELECTRONICS BANDWIDTH AND INTEGRATING EFFECT OF R<sub>50</sub>(C<sub>D</sub>+C<sub>D</sub>)



### Transient current signals

Simplified parallel plate 1D geometry

$$i_{tr}(E) = \frac{Q_0}{d} \cdot v(E(x)) \cdot \exp(-t/\tau_{eff-h,e})$$

$$E(x) = E(extr) - \frac{q_0}{\varepsilon \varepsilon_{diam}} \int_0^d N_{eff}(x') dx'$$



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close to "IDEAL"

time[ns]

electrons holes

E~1[V/µm]

0.10

0.08

0.06

0.04

0.02

0.00

output signal [V]

$$V_{dr} = \frac{\mu_0 \cdot E}{1 + \frac{\mu_0}{v_{sat}} \cdot E}$$

**DATA POINTS FROM 6 SAMPLES** 

# Velocity and mobility

holes (one fit )

 $\mu_0\cong \textbf{2400 [cm²/Vs] (±300)}$ 

 $V_{\text{sat}}\cong \textbf{140} \text{ [}\mu\text{m/ns]}$ 



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### Charge collection - $\Delta E$ Spectroscopy



# Irradiation 26 MeV protons



Cyclotron facility in Karlsruhe

Continuous scanning of selected areas: Beam currents used:  $0.6\mu A$  ,  $6\mu A$  and  $12\mu A$ 

Homogeneous depth profile of irradiation for 300-500microns diamonds.

Off-line fluency verificationactivation of Ni57 foils. Error ~2% Three samples of different history used previously in heavy ion experiments at GSI:

BDS14 - 4x4x0.49 mm3 - Cr(50nm); Au(100nm)

EBS3 - 3.5x3.5x0.39 mm3 - Cr(50nm);Au(100nm)

BDS13 - 4x4x0.48 mm3 - Cr(50nm);Au(100nm)

Total dose absorbed before irradiation is not known



# **Radiation related defects**



# Transient signals after irradiation



Samples annealed at 400°C

only 100 events per step ~30s

exponential decay due to trapping

transient time does not change  $\rightarrow$  not visible space charge

creation of neutral defects (?)

BDS13 - gives no TC signals

very short life time <100ps

Bandwidth and noise limitation

CCE % is not a good parameter – thickness dependence

# **Traps passivation – priming effect**



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# CCE after priming



# Defects annealing



temperature dependence

dynamic at 700°C

#### ND1 > 500°C; GR1 annealing > 650°C

... but vacancies become mobile ... can form new centers

H3 A-aggregate bound to two vacancies > 1400°C NV and NV- nitrogen-vacancy pairs >1500°C and others...

### $T_{eff}$ - effective trapping time



a good parameter  $\tau_{eff}$  ..... and even better ...  $t_{tr}/\tau_{eff}$ 

Annealing at 1000°C in Ar



~70% "holes active" defects annealed out ~50% for "electrons active"

Higher activation energy(?), different order kinetics(?)

#### SUMMARY

Non-irradiated SC CVD Diamond detectors:

- high purity intrinsic material  $\rightarrow$  suitable for  $\Delta E$  spectroscopy
- $T_{eff}$  >> transient time --> CCE ~ 100% at low E
- high and comparable charge carriers velocity
- operation close to drift velocity saturation range; transient signals 1ns/100µm

#### Heavily irradiated SC CVD Diamond detectors:

- creation of deep donors and acceptors
- strong decrease of leakage current  $\rightarrow$  no contribution to the noise
- symmetrically decrease of  $\tau_{\mbox{\tiny eff}}$  for e and h after irradiation
- no space charge observed  $\rightarrow$  mainly neutral defects(?)
- priming effect  $\rightarrow$  polarization and increase of  $\tau_{_{eff}}$  for traversing particles
- created defects can be annealed but asymmetry in defects annealing for e and h

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